

Learning Theory, Overfitting, Bias Variance Decomposition

Machine Learning 10-601B

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Many of these slides are derived from Tom Mitchell, Ziv-Bar Joseph. Thanks!

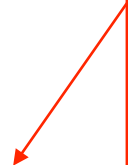
How many examples will ϵ -exhaust the VS?

Theorem: [Haussler, 1988].

If the hypothesis space H is finite, and D is a sequence of $m \geq 1$ independent random examples of some target concept c , then for any $0 \leq \epsilon \leq 1$, the probability that the version space with respect to H and D is not ϵ -exhausted (with respect to c) is less than

$$|H|e^{-\epsilon m}$$

Interesting! This bounds the probability that any consistent learner will output a hypothesis h with $error(h) \geq \epsilon$



Any(!) learner that outputs a hypothesis consistent with all training examples (i.e., an h contained in $VS_{H,D}$)

What it means

[Haussler, 1988]: probability that the version space is not ϵ -exhausted after m training examples is at most $|H|e^{-\epsilon m}$



Suppose we want this probability to be at most δ

$$\Pr[(\exists h \in H) s.t. (error_{train}(h) = 0) \wedge (error_{true}(h) > \epsilon)] \leq |H|e^{-\epsilon m}$$

1. How many training examples suffice?

$$m \geq \frac{1}{\epsilon} (\ln |H| + \ln(1/\delta))$$


Agnostic Learning

So far, assumed $c \in H$

Agnostic learning setting: don't assume $c \in H$

- What do we want then?
 - The hypothesis h that makes fewest errors on training data
- What is sample complexity in this case?

$$m \geq \frac{1}{2\epsilon^2}(\ln |H| + \ln(1/\delta))$$



Here ϵ is the difference between the training error and true error of the output hypothesis (the one with lowest training error)

Additive Hoeffding Bounds – Agnostic Learning

- Given m independent flips of a coin with true $\Pr(\text{heads}) = \theta$
we can bound the error ϵ in the maximum likelihood estimate $\hat{\theta}$

$$\Pr[\theta > \hat{\theta} + \epsilon] \leq e^{-2m\epsilon^2}$$

- Relevance to agnostic learning: for any single hypothesis h

$$\Pr[\text{error}_{\text{true}}(h) > \text{error}_{\text{train}}(h) + \epsilon] \leq e^{-2m\epsilon^2}$$

- But we must consider all hypotheses in H

$$\Pr[(\exists h \in H) \text{error}_{\text{true}}(h) > \text{error}_{\text{train}}(h) + \epsilon] \leq |H|e^{-2m\epsilon^2}$$

- Now we assume this probability is bounded by δ . Then, we have

$$m > \frac{1}{\epsilon^2} (\ln |H| + \ln(1/\delta))$$

$$m \geq \frac{1}{\epsilon} (\ln |H| + \ln(1/\delta))$$

Question: If $H = \{h \mid h: X \rightarrow Y\}$ is infinite, what measure of complexity should we use in place of $|H|$?

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Answer: The largest subset of X for which H can guarantee zero training error (regardless of the target function c)

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Question: If $H = \{h \mid h: X \rightarrow Y\}$ is infinite, what measure of complexity should we use in place of $|H|$?

Answer: The largest subset of X for which H can guarantee zero training error (regardless of the target function c)

VC dimension of H is the size of this subset

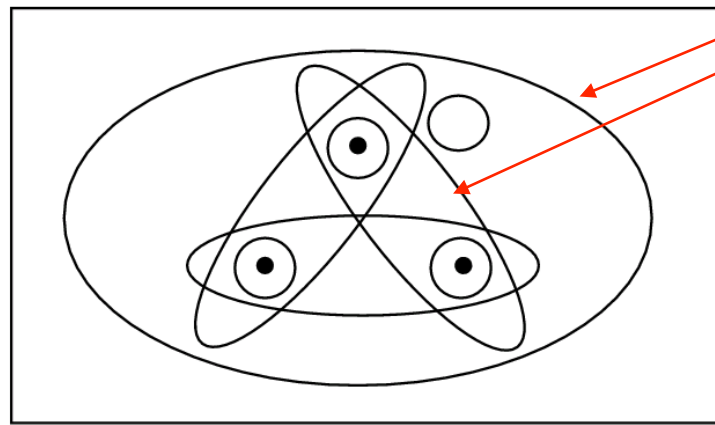
Shattering a Set of Instances

Definition: a **dichotomy** of a set S is a partition of S into two disjoint subsets.

a labeling of each member of S as positive or negative

Definition: a set of instances S is **shattered** by hypothesis space H if and only if for every dichotomy of S there exists some hypothesis in H consistent with this dichotomy.

Instance space X



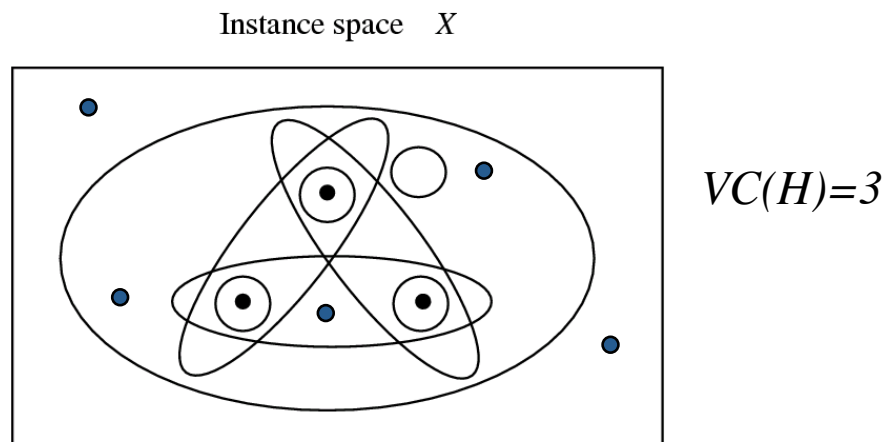
Each ellipse corresponds to a possible dichotomy

Positive: Inside the ellipse

Negative: Outside the ellipse

The Vapnik-Chervonenkis Dimension

Definition: The **Vapnik-Chervonenkis dimension**, $VC(H)$, of hypothesis space H defined over instance space X is the size of the largest finite subset of X shattered by H . If arbitrarily large finite sets of X can be shattered by H , then $VC(H) \equiv \infty$.



Sample Complexity based on VC dimension

How many randomly drawn examples suffice to ϵ -exhaust $VS_{H,D}$ with probability at least $(1-\delta)$?

ie., to guarantee that any hypothesis that perfectly fits the training data is probably $(1-\delta)$ approximately (ϵ) correct

$$m \geq \frac{1}{\epsilon} (4 \log_2(2/\delta) + 8VC(H) \log_2(13/\epsilon))$$

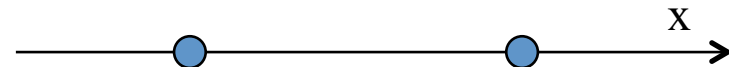
Compare to our earlier results based on $|H|$:

$$m \geq \frac{1}{\epsilon} (\ln(1/\delta) + \ln |H|)$$

VC dimension: examples

Consider 1-dim real valued input X , want to learn $c: X \rightarrow \{0,1\}$

What is VC dimension of



- Open intervals:

H1: if $x > a$ then $y = 1$ else $y = 0$

H2: if $x > a$ then $y = 1$ else $y = 0$
or, if $x > a$ then $y = 0$ else $y = 1$

- Closed intervals:

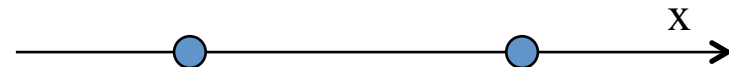
H3: if $a < x < b$ then $y = 1$ else $y = 0$

H4: if $a < x < b$ then $y = 1$ else $y = 0$
or, if $a < x < b$ then $y = 0$ else $y = 1$

VC dimension: examples

Consider 1-dim real valued input X , want to learn $c: X \rightarrow \{0,1\}$

What is VC dimension of



- Open intervals:

H1: if $x > a$ then $y = 1$ else $y = 0$ $VC(H1)=1$

H2: if $x > a$ then $y = 1$ else $y = 0$ $VC(H2)=2$
or, if $x > a$ then $y = 0$ else $y = 1$

H2 can perfectly handle if there is 2 X sample

- Closed intervals:

H3: if $a < x < b$ then $y = 1$ else $y = 0$ $VC(H3)=2$

H4: if $a < x < b$ then $y = 1$ else $y = 0$ $VC(H4)=3$
or, if $a < x < b$ then $y = 0$ else $y = 1$

VC dimension: examples

What is VC dimension of lines in a plane?

- $H_2 = \{ ((w_0 + w_1x_1 + w_2x_2) > 0 \rightarrow y=1) \}$



VC dimension: examples

What is VC dimension of

- $H_2 = \{ ((w_0 + w_1x_1 + w_2x_2) > 0 \rightarrow y=1) \}$
 - $VC(H_2)=3$
- For $H_n =$ linear separating hyperplanes in n dimensions,
 $VC(H_n)=n+1$



**For any finite hypothesis space H , can you
give an upper bound on $VC(H)$ in terms of $|H|$?
(hint: yes)**

Assume $VC(H) = K$, which means H can shatter K examples.

For K examples, there are 2^K possible labelings. Thus, $|H| \geq 2^K$

Thus, $K \leq \log_2 |H|$

Tightness of Bounds on Sample Complexity

How many examples m suffice to assure that any hypothesis that fits the training data perfectly is probably $(1-\delta)$ approximately (ϵ) correct?

$$m \geq \frac{1}{\epsilon} (4 \log_2(2/\delta) + 8VC(H) \log_2(13/\epsilon))$$

How tight is this bound?

Tightness of Bounds on Sample Complexity

How many examples m suffice to assure that any hypothesis that fits the training data perfectly is probably $(1-\delta)$ approximately (ϵ) correct?

$$m \geq \frac{1}{\epsilon} (4 \log_2(2/\delta) + 8VC(H) \log_2(13/\epsilon))$$

How tight is this bound?

Lower bound on sample complexity (Ehrenfeucht et al., 1989):

Consider any class C of concepts such that $VC(C) > 1$, any learner L , any $0 < \epsilon < 1/8$, and any $0 < \delta < 0.01$. Then there exists a distribution and a target concept in C , such that if L observes fewer examples than

$$\max \left[\frac{1}{\epsilon} \log(1/\delta), \frac{VC(C) - 1}{32\epsilon} \right]$$

Then with probability at least δ , L outputs a hypothesis with

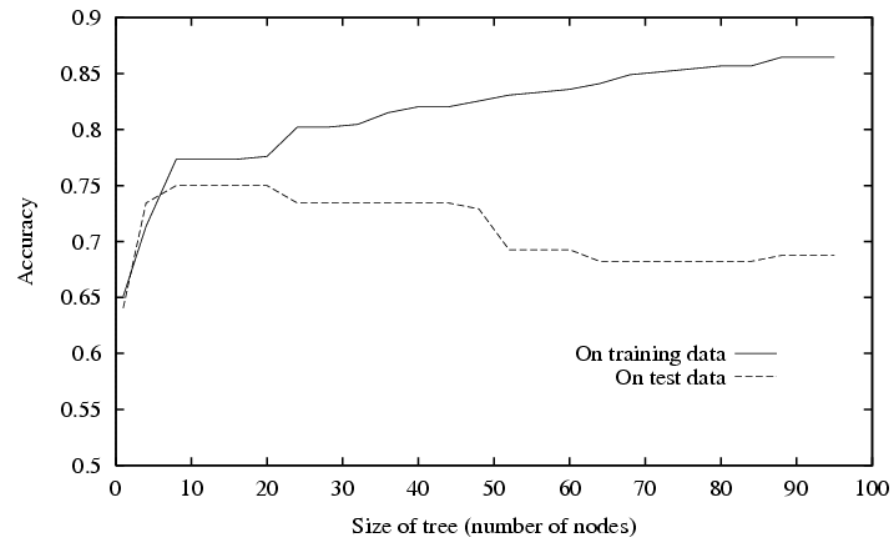
$$error_{\mathcal{D}}(h) > \epsilon$$

Agnostic Learning: VC Bounds for Decision Tree

[Schölkopf and Smola, 2002]

With probability at least $(1-\delta)$ every $h \in H$ satisfies

$$error_{true}(h) < error_{train}(h) + \sqrt{\frac{VC(H)(\ln \frac{2m}{VC(H)} + 1) + \ln \frac{4}{\delta}}{m}}$$

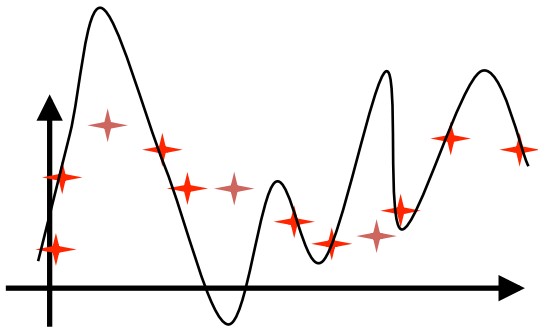


What You Should Know

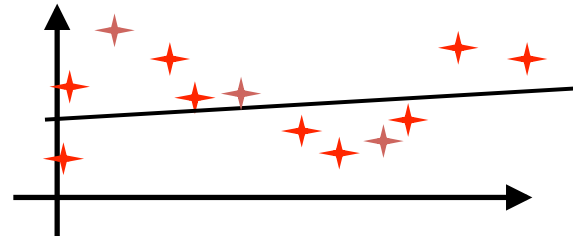
- Sample complexity varies with the learning setting
 - Learner actively queries trainer
 - Examples arrive at random
- Within the PAC learning setting, we can bound the probability that learner will output hypothesis with given error
 - For ANY consistent learner (case where $c \in H$)
 - For ANY “best fit” hypothesis (agnostic learning, where perhaps c not in H)
- VC dimension as a measure of complexity of H
- Conference on Learning Theory: <http://www.learningtheory.org>
- Avrim Blum’s course on Machine Learning Theory:
 - <https://www.cs.cmu.edu/~avrim/ML14/>

OVERFITTING, BIAS/VARIANCE TRADE-OFF

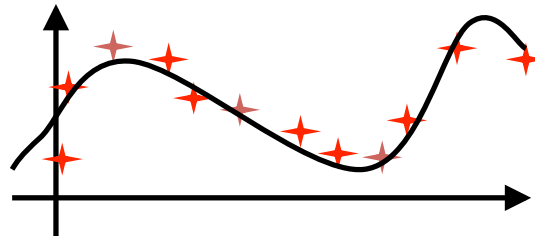
What is a good model?



Low Robustness






Low quality /High Robustness



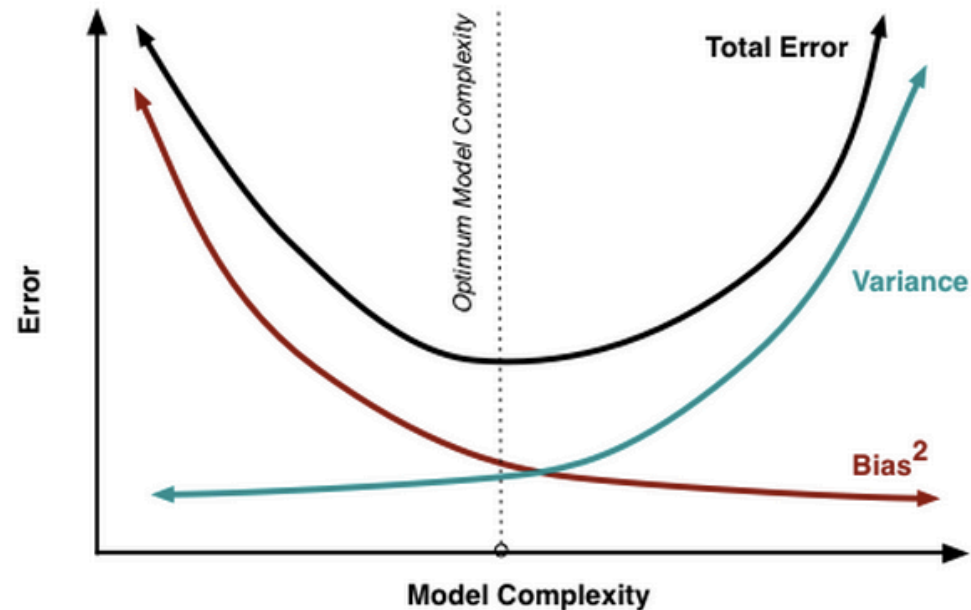
Robust Model

LEGEND

-  Model built
-  Known Data
-  New Data₂

Two sources of errors

- Now let's look more closely into two sources of errors in a function approximator:



- In the following we show how bias and variance decompose

Expected loss, Bias/Variance Decomposition

- Let y be the **true** (target) output
- Let $h(x) = E[y|x]$ be the **optimal** predictor
- Let $f(x)$ our actual predictor, which will incur the following expected loss

$$\begin{aligned} E(f(x) - y)^2 &= \int (f(x) - y)^2 p(x, y) dx dy \\ &= \int (f(x) - h(x) + h(x) - y)^2 p(x, y) dx dy \\ &= \int \left[(f(x) - h(x))^2 + 2(f(x) - h(x))(h(x) - y) + (h(x) - y)^2 \right] p(x, y) dx dy \\ &= \underbrace{\int (f(x) - h(x))^2 p(x) dx}_{\text{The part we can influence by changing our predictor } f(x)} + \underbrace{\int (h(x) - y)^2 p(x, y) dx dy}_{\text{a noise term, and we can do no better than this. Thus it is a lower bound of the expected loss}} \end{aligned}$$

The part we can influence by changing our predictor $f(x)$

a noise term, and we can do no better than this. Thus it is a lower bound of the expected loss

Expected loss, Bias/Variance Decomposition

$$E(f(x) - y)^2 = \int (f(x) - h(x))^2 p(x) dx + \int (h(x) - y)^2 p(x, y) dx dy$$

- $f(x; D)$: We will assume $f(x) = f(x|w)$ is a parametric model and the parameters w are fit to a training set D .
- $E_D[f(x; D)]$: The expected predictor over the multiple training datasets

Take the expectation over different datasets

$$E_D \left[(f(x; D) - h(x))^2 \right] = \underbrace{(E_D[f(x; D)] - h(x))^2}_{\text{Bias}^2} + \underbrace{E_D \left[(f(x; D) - E_D[f(x; D)])^2 \right]}_{\text{Variance}}$$

Bias²

Variance

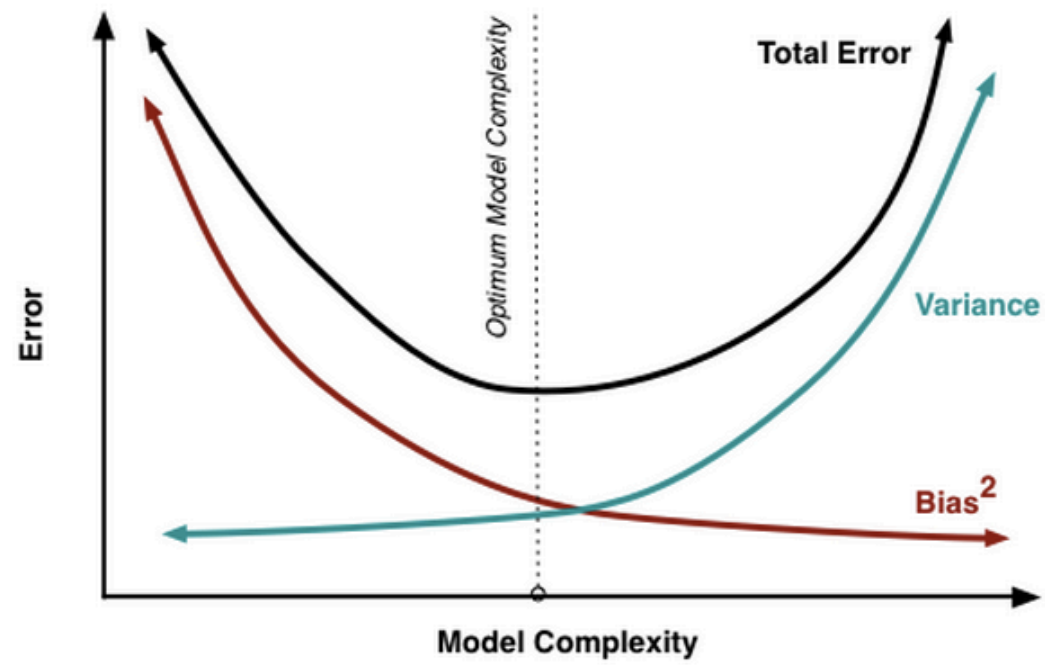
Expected loss, Bias/Variance Decomposition

Proof:

$$\begin{aligned} E_D[(f(x;D) - h(x))^2] &= E_D[(f(x;D) - E_D[f(x;D)] + E_D[f(x;D)] - h(x))^2] \\ &= E_D[(f(x;D) - E_D[f(x;D)])^2 + (E_D[f(x;D)] - h(x))^2 \\ &\quad + 2(f(x;D) - E_D[f(x;D)])(E_D[f(x;D)] - h(x))] \\ &= \underbrace{(E_D[f(x;D)] - h(x))^2}_{\text{Bias}^2} + \underbrace{E_D[(f(x;D) - E_D[f(x;D)])^2]}_{\text{Variance}} \end{aligned}$$

- Putting things together:

expected loss = (bias)² + variance + noise



$$\text{expected loss} = (\text{bias})^2 + \text{variance} + \text{noise}$$

Regularized Regression

- Recall linear regression: $\mathbf{y} = \mathbf{X}^T \boldsymbol{\beta} + \varepsilon$
$$\boldsymbol{\beta}^* = \arg \max_{\boldsymbol{\beta}} (\mathbf{y} - \mathbf{X}^T \boldsymbol{\beta})^T (\mathbf{y} - \mathbf{X}^T \boldsymbol{\beta})$$
$$= \arg \max_{\boldsymbol{\beta}} \|\mathbf{y} - \mathbf{X}^T \boldsymbol{\beta}\|^2$$

- Regularized LR:

- L2-regularized LR:

$$\boldsymbol{\beta}^* = \arg \max_{\boldsymbol{\beta}} \|\mathbf{y} - \mathbf{X}^T \boldsymbol{\beta}\|^2 + \lambda \|\boldsymbol{\beta}\|$$

where

$$\|\boldsymbol{\beta}\| = \sum_i \beta_i^2$$

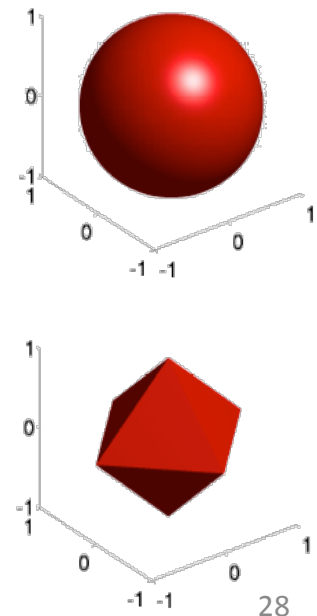
- L1-regularized LR:

$$\boldsymbol{\beta}^* = \arg \max_{\boldsymbol{\beta}} \|\mathbf{y} - \mathbf{X}^T \boldsymbol{\beta}\|^2 + \lambda |\boldsymbol{\beta}|$$

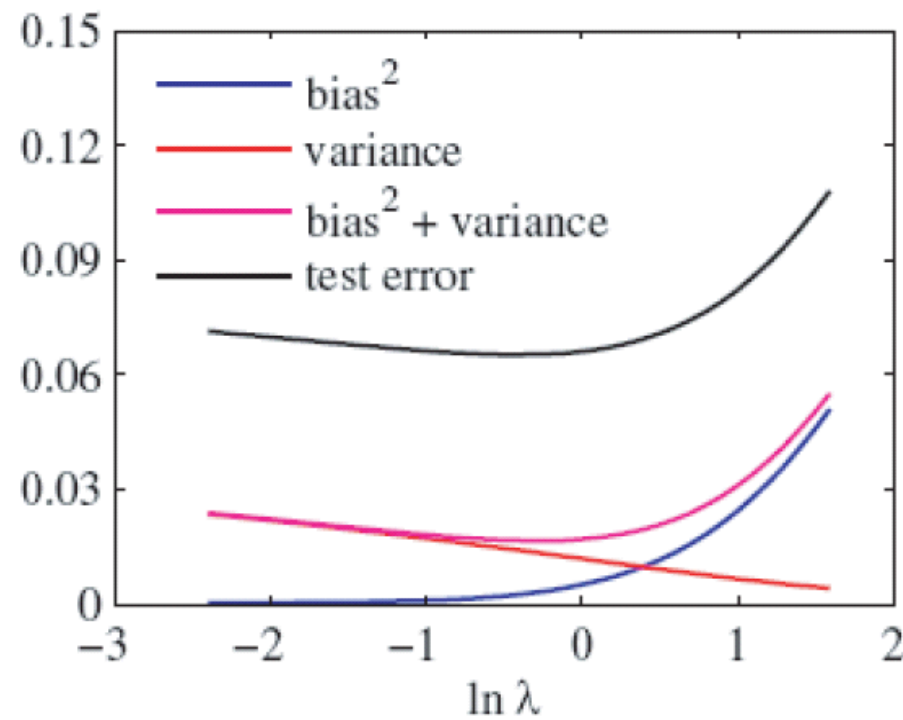
where

$$|\boldsymbol{\beta}| = \sum_i |\beta_i|$$

λ controls bias/variance trade off



Bias²+variance vs regularizer



- Bias²+variance predicts (shape of) test error quite well.
- However, bias and variance cannot be computed since it relies on knowing the true distribution of x and y (and hence $h(x) = E[y|x]$).

Bayes Error Rate

- Fundamental performance limit for classification problem
- A lower bound on classification performance of *any* algorithms on a given problem
 - i.e., Error rate of the optimal decision rule

Bayes Error Rate: Two Class

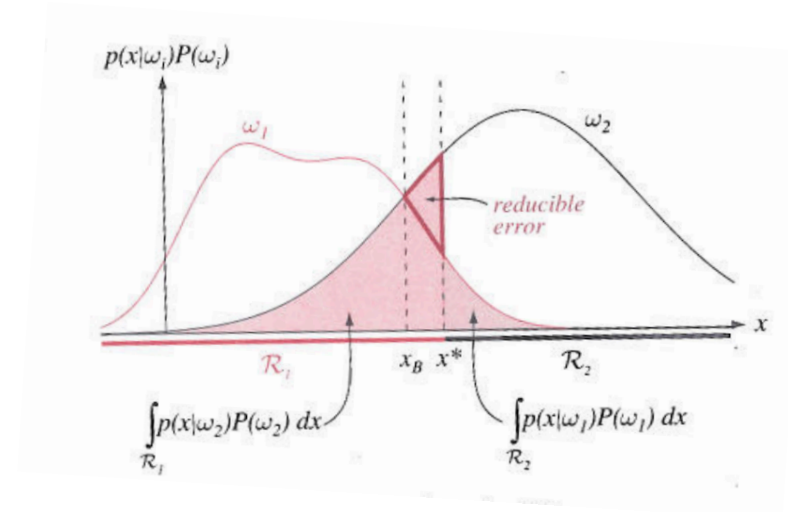
- For a two-class classification problem
 - \mathbf{x} is input feature vector, and ω_1, ω_2 are two classes
 - Then, Bayes optimal decision rule is

- Classify as ω_1 if

$$P(\mathbf{x} | \omega_1)P(\omega_1) > P(\mathbf{x} | \omega_2)P(\omega_2)$$

- Classify as ω_2 if

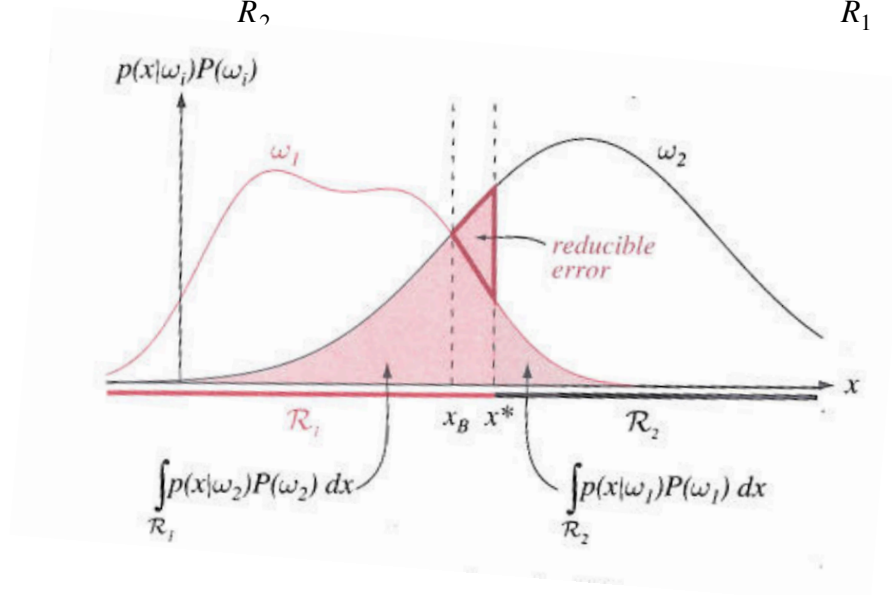
$$P(\mathbf{x} | \omega_1)P(\omega_1) < P(\mathbf{x} | \omega_2)P(\omega_2)$$



Bayes Error Rate: Two Class

- For a two-class classification problem
 - \mathbf{x} is input feature vector, and ω_1, ω_2 are two classes
 - Given this optimal decision rule, the error rate is

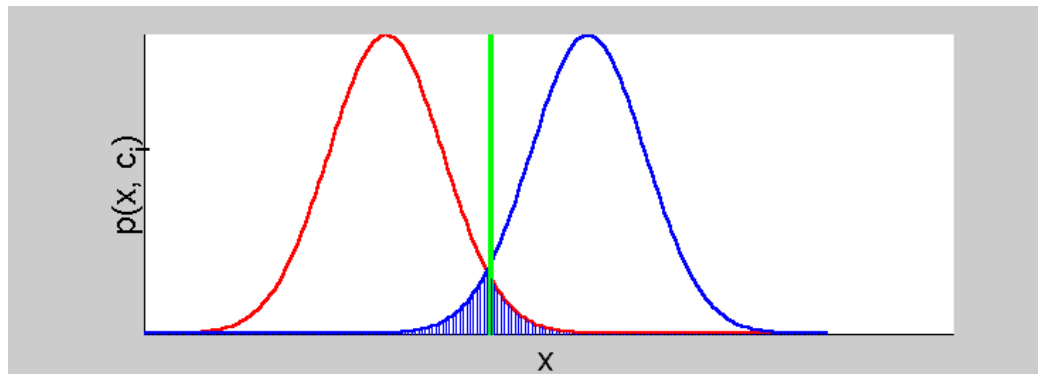
$$\begin{aligned} P(\text{error}) &= P(\mathbf{x} \in R_2, \omega_1) + P(\mathbf{x} \in R_1, \omega_2) \\ &= P(\mathbf{x} \in R_2 | \omega_1)P(\omega_1) + P(\mathbf{x} \in R_1 | \omega_2)P(\omega_2) \\ &= \int_{R_2} P(\mathbf{x} \in R_2 | \omega_1)P(\omega_1)d\mathbf{x} + \int_{R_1} P(\mathbf{x} \in R_1 | \omega_2)P(\omega_2)d\mathbf{x} \end{aligned}$$



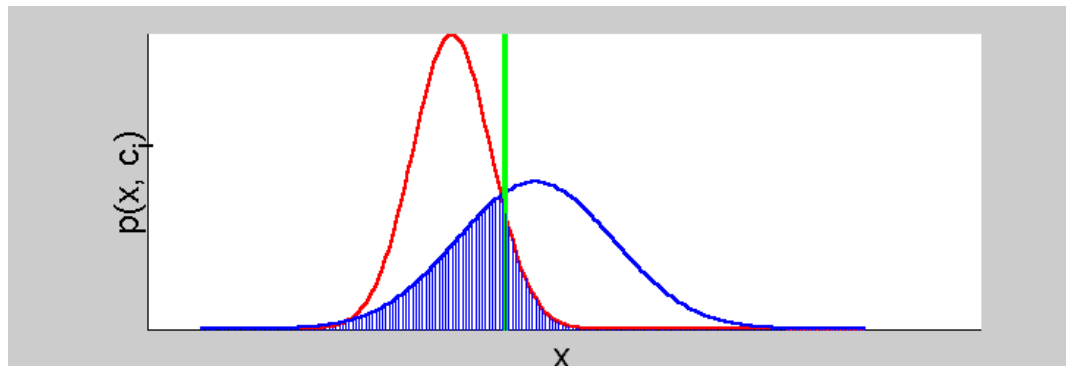
Bayes error rate gives the irreducible error: fundamental property of the problem, not the classifier

Classification Example

- Simple problem



- Hard problem



Bayes Error Rate: Multiple Classes

- For c-class classification

$$\begin{aligned}P(\textit{correct}) &= \sum_{i=1}^c P(\mathbf{x} \in R_i, \omega_i) \\&= \sum_{i=1}^c P(\mathbf{x} \in R_i \mid \omega_i) P(\omega_i) \\&= \sum_{i=1}^c \int_{R_i} P(\mathbf{x} \in R_i \mid \omega_i) P(\omega_i) d\mathbf{x}\end{aligned}$$

$$P(\textit{error}) = 1 - P(\textit{correct})$$

Summary

- Overfitting
- Bias-variance decomposition
- Bayes Error Rate